

# **MXD8116LE**

SP6T LNA LTE RX Module



This document contains information that is confidential and proprietary to Maxscend Microelectronics Company Limited (Maxscend) and may not be reproduced in any form without express written consent of Maxscend. No transfer or licensing of technology is implied by this document.

Page 1 of 7



## **General Description**

The MXD8116LE is an LTE RX module integrated with a low noise, high gain LNA and low insertion loss SP6T, which is used for multiinput for LTE RX.

The MXD8116LE is compatible with +1.0V control logic, which is a key requirement for most cellular transceivers. This part is packaged in a compact 2mm x 2mm, 14-pin, QFN package which allows for a small solution size with no need for external DC blocking capacitors.

## **Applications**

LTE low band receiving

## Features

- Operation frequency range: 720 to 970 MHz
- 17dB gain at 720 to 970 MHz
- Low noise figure:
  - 1.0 dB at 720MHz to 970 MHz
- Operation current 6mA
- Compact 2mm x 2mm in QFN-14 package , MSL1
- No DC blocking capacitors required

# **Functional Block Diagram and Pin Function**



#### Figure 1 Functional Block Diagram and Pinout (Top View)



# **Application Circuit**



Figure 2 MXD8116LE Evaluation Board Schematic

### Table 1. Pin Description

Pin No.	Name	Description	Pin No.	Name	Description
1	RF5	RF port 5	8	NC	No connection
2	RF3	RF port 3	9	RF2	RF port2
3	RF1	RF port 1	10	RF4	RF port4
4	VDD	Power supply	11	RF6	RF port6
5	V3	Digital control 3	12	NC	No connection
6	V2	Digital control 2	13	RFOUT	RF output
7	V1	Digital control 1	14	NC	No connection
Ground Paddle	GND	Ground			

Note: Bottom ground paddles must be connected to ground.

## Table 2.

Component	Vendor	Туре	Part Number & value
	Murata	Wired inductor, high Q	LQW15AN33N, 33nH
L1,L2,L3,L4,L5,L6	various	Ceramic inductor, low Q	30nH

## **Truth Table**

Table 3.

V1	V2	V3	Active Path
0	0	0	RF1 active
0	0	1	RF2 active
0	1	0	RF3 active



#### MXD8116LE – SP6T LNA LTE RX Module

0	1	1	RF4 active
1	0	0	RF5 active
1	0	1	RF6 active
1	1	1	Power down

**Note:** "1" = 1.0 V to 3.00 V. "0" = -0 V to +0.3 V.

# **Recommended Operation Range**

#### Table 4.

Recommended Operation Range						
Table 4.						
Parameters	Symbol	Min	Тур	Max	Units	
Operation Frequency	f1	720	-	970	MHz	
Power supply	V <sub>DD</sub>	2.5	2.8	3.0	V	
Switch Control Voltage High	V <sub>CTL_H</sub>	1.6	1.8	3.0	V	
Switch Control Voltage Low	V <sub>CTL_L</sub>	0	0	0.3	V	

## **Specifications**

## **Table 5. Electrical Specifications**

Devenetor	Cumhal	Specification		L luite	Test Condition		
Parameter	Symbol	Min.	Typical	Max.	Units	Test Condition	
DC Specifications							
Control voltage:							
Low	V <sub>CTL_L</sub>	0	+1.8	0.3	V		
High	V <sub>CTL_H</sub>	1.60		3.00	V		
Supply voltage	V <sub>DD</sub>	2.5	2.8	3.0	V		
Supply current	I <sub>DD</sub>		6		mA	VDD = 2.8 V	
Power down current	I <sub>PD</sub>		1		uA		
<b>RF Specifications</b>							
Power gain	G	15	17	18.5	dB	720 to 970MHz	
Noise figure	NF	-	1.0	1.5	dB	720 to 970MHz	
Input Return loss	S11	-	-10	-5	dB	720 to 970MHz	
Isolation(Active path gain – off path gain)	ISO	20	25	-	dB	720 to 970MHz	
Output Return loss	S22	-	-10	-6	dB	720 to 970MHz	
Input Power 1-dB Compression Point		-14	-11	-	dBm	720 to 970MHz	
Switching on time		-	2	3	μs	50% VCTL to 10/90% RF	
Switching off time		-	2	3	μs	50% VCTL to 90/10% RF	
Startup time		-	5	6	μs	Shutdown state to any RF switch state	

# **Absolute Maximum Ratings**

## Table 6. Maximum ratings

Parameters	Symbol	Symbol Minimum		Units	
Supply voltage	V <sub>DD</sub>	+2.0	+3.3	V	
Control voltage (V1, V2, and V3)	V <sub>CTL</sub>	0	+3.0	V	
RF input power (RF1 to RF6)	P <sub>IN</sub>		+10	dBm	
Operating temperature	T <sub>OP</sub>	-35	+90	°C	
Storage temperature	T <sub>STG</sub>	-40	+125	°C	
Electrostatic Discharge					
Human body model (HBM), Class 1C	ESD_HBM		1000	V	
Machine Model (MM), Class A	ESD_MM		100	v	
Charged device model (CDM), Class III	ESD_CDM		500		



#### MXD8116LE – SP6T LNA LTE RX Module

Note: Exposure to maximum rating conditions for extended periods may reduce device reliability. There is no damage to device with only one parameter set at the limit and all other parameters set at or below their nominal value. Exceeding any of the limits listed here may result in permanent damage to the device

## **Package Outline Dimension**







## **Marking Specification**



Figure 4 Marking specification (Top View)

## **Tape and Reel Dimensions**



#### Figure 5 Tape and reel dimensions

Page 6 of 7



**Reflow Chart** 



Figure 6 Recommended Lead-Free Reflow Profile

#### Table 7. Reflow condition

Profile Parameter	Lead-Free Assembly, Convection, IR/Convection			
Ramp-up rate $(TS_{max} to T_p)$	3°C/second max.			
Preheat temperature (TS <sub>min</sub> to TS <sub>max</sub> )	150℃ to 200℃			
Preheat time (t <sub>s</sub> )	60 - 180 seconds			
Time above TL , 217 $^\circ\!\!\!{\rm C}$ $(t_L)$	60 - 150 seconds			
Peak temperature (T <sub>p</sub> )	<b>260</b> ℃			
Time within 5°C of peak temperature( $t_p$ )	20 - 40 seconds			
Ramp-down rate	6°C/second max.			
Time 25 <sup>°</sup> C to peak temperature	8 minutes max.			

## **ESD Sensitivity**

Integrated circuits are ESD sensitive and can be damaged by static electric charge. Proper ESD protection techniques should be used when handling these devices.

# **RoHS Compliant**

This product does not contain lead, mercury, cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE), and are considered RoHS compliant.